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EXAMINER

U.S. Dept. of Commerce, Patent and Trademarks LIST OF ART CITED BY APPLICANT (Use several sheets if necessary Attorney Docket No. Filing Date Serial No. 10/038,943 **DECEMBER 31, 2001** A-7597 Applicant: Group NALLUR ET AL. 2613 **U.S. PATENT DOCUMENTS** Document No. Date Name Class Subclass Exami ner's Initial AA5,377,051 12/27/94 Lane et al. 360 33.1 DT RECEIVED AB MAY 1 5 2003 AC Technology Center 2600 AD **AE** FOREIGN PATENT DOCUMENTS Document No. Date Country Class Translation Subclass AF AG AH AI OTHER PRIOR ART (Including Author Title, Date, Pertinent Pages, Etc.) ΑJ AK AL

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance. Include copy of this form with next communication to Applicant.

/Daniel Tekle/

DATE CONSIDERED:

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